Search Notes

Application/Control No.	Applicant(s)/Paten Reexamination	t under
10/517,445	NISHII ET AL.	
Examiner	Art Unit	
Donahai D. Nauven	3720	

SEARCHED					
Class	Subclass	Date		Examiner	
29	825, 829- 831, 846 848, 851	10/11/2006		m	
156	102, 228				
	230, 233				
	582				
	583.1				
174	262				
216	20				
428	96	V	/	U	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		_			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East: Text and Inventors' Names Search (see attachment)	10/11/2006	W		
Plus Search (see attached)				